Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/532,845	LU ET AL.
Examiner	Art Unit
Y. Lee	2621

SEARCHED				
Class	Subclass	Date	Examiner	
375	240.01 240.12 240.13 240.29	6/18/2008	YL	
H04N	7/12			
update	search	3/3/2009	YL	
update	search	7/21/2009	YL	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		